	Application/Control No.	Applicant(s)/Patent Under Reexamination
Index of Claims	10593424	RITTER ET AL.
	Examiner	Art Unit
	Hai Phan	2614

✓	Rejected	-	- Cancelled		Non-Elected	A	Appeal
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☐ Claims renumbered in the same order as presented by applicant ☐ CPA ☐ T.D. ☐ F									R.1.47					
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